

N-Channel 900V (D-S) Super Junction Power MOSFET

PRODUCT SUMMA	RY	
V _{DS} (V)	90	00
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V	0. 95
Q _g (Max.) (nC)	200)
Q _{gs} (nC)	24	
Q _{gd} (nC)	110)
Configuration	Sing	le

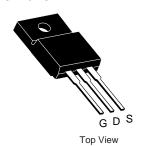
FEATURES

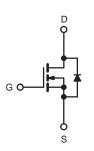
- Dynamic dV/dt Rating
- Repetitive Avalanche Rated
- Isolated Central Mounting Hole
- Fast Switching
- Ease of Paralleling
- Simple Drive Requirements
- Compliant to RoHS Directive 2002/95/EC





TO-220 FULLPAK





N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	900	V	
Gate-Source Voltage			V_{GS}	± 20	V	
Continuous Drain Current	V _{GS} at 10 V	T _C = 25 °C	I _D	7.0		
	VGS at 10 V	T _C = 100 °C		5.5	Α	
Pulsed Drain Current ^a			I _{DM}	21		
Linear Derating Factor				1.5	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	770	mJ	
Repetitive Avalanche Currenta			I _{AR}	7.8	Α	
Repetitive Avalanche Energy ^a			E _{AR}	19	mJ	
Maximum Power Dissipation	T _C =	25 °C	P _D	65	W	
Peak Diode Recovery dV/dt ^c			dV/dt	2.0	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s	-	300 ^d		
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
				1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 23 mH, $R_g = 25$ Ω , $I_{AS} = 7.8$ A (see fig. 12). c. $I_{SD} \le 7.8$ A, dl/dt ≤ 140 A/ μ s, $V_{DD} \le 600$ V, $T_J \le 150$ °C. d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATI	NGS			
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R _{thJA}	-	40	
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.65	

SPECIFICATIONS ($T_J = 25 ^{\circ}\text{C}$, u	illess officiwi	se notea)				•	1
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V_{DS}	V _{GS}	$= 0 \text{ V}, I_D = 250 \mu\text{A}$	900	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Referenc	e to 25 °C, I _D = 1 mA	-	0.98	-	V/°C
Gate-Source Threshold Voltage	$V_{GS(th)}$	V _{DS} :	$= V_{GS}, I_D = 250 \mu A$	2.0	-	4.0	V
Gate-Source Leakage	I_{GSS}		$V_{GS} = \pm 20 \text{ V}$	i	-	± 100	nA
Zero Gate Voltage Drain Current	I _{DSS}		= 900 V, V _{GS} = 0 V /, V _{GS} = 0 V, T _J = 125 °C	1	-	100 500	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 5.6 A ^b	-	-	0.95	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	: 100 V, I _D = 5.6 A ^b	5.6	-	-	S
Dynamic					ı	l .	
Input Capacitance	C _{iss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. 5}$		-	3100	-	
Output Capacitance	C _{oss}			-	800	-	pF
Reverse Transfer Capacitance	C _{rss}			-	490	-	
Total Gate Charge	Qg			-	-	200	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V	$I_D = 3.8 \text{ A}, V_{DS} = 400 \text{ V},$ see fig. 6 and 13 ^b	-	-	24	
Gate-Drain Charge	Q _{gd}	see fig. 6 and 135		-	-	110	1
Turn-On Delay Time	t _{d(on)}			-	19	-	
Rise Time	t _r	$V_{DD} = 400 \text{ V, } I_{D} = 5.6 \text{ A,}$ $R_{g} = 6.2 \Omega, R_{D} = 52 \Omega$ see fig. 10^{b}		-	38	-	- ns
Turn-Off Delay Time	t _{d(off)}			-	120	-	
Fall Time	t _f			-	39	-	
Internal Drain Inductance	L _D	6 mm (0.25")	Between lead, 6 mm (0.25") from		5.0	-	
Internal Source Inductance	L _S	package and center of die contact		-	13	-	nH
Drain-Source Body Diode Characteristic	s						•
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	5.0	_
Pulsed Diode Forward Current ^a	I _{SM}			-	-	21	A
Body Diode Voltage	V _{SD}	T _J = 25 °C, I _S = 5.6 A, V _{GS} = 0 V ^b		-	-	1.8	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 5.6 A, dl/dt = 100 A/μs ^b		-	650	980	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	3.8	5.7	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-on time is negligible (turn-on is dom			ninated b	y L _s and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. Pulse width \leq 300 µs; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

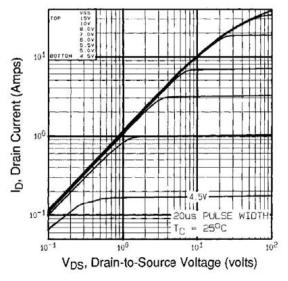


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

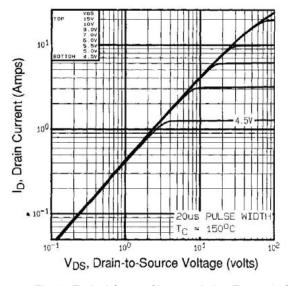


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

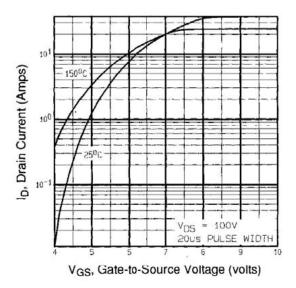


Fig. 3 - Typical Transfer Characteristics

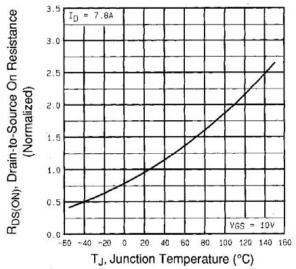


Fig. 4 - Normalized On-Resistance vs. Temperature



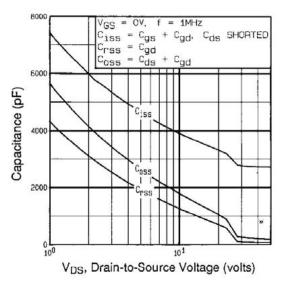


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

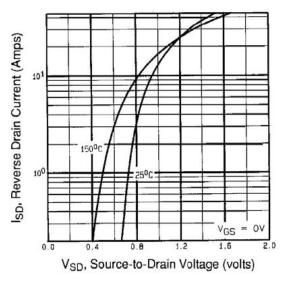


Fig. 7 - Typical Source-Drain Diode Forward Voltage

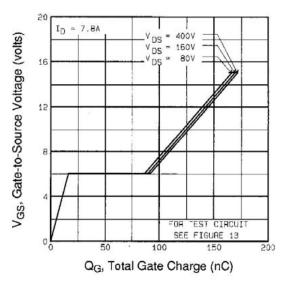


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

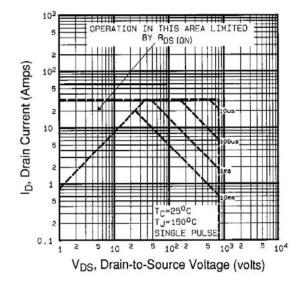


Fig. 8 - Maximum Safe Operating Area



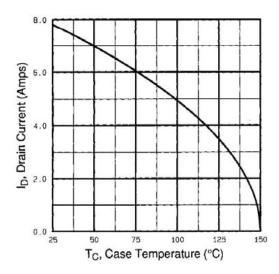


Fig. 9 - Maximum Drain Current vs. Case Temperature

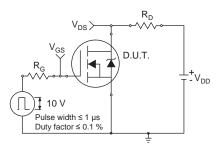


Fig. 10a - Switching Time Test Circuit

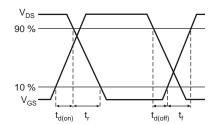


Fig. 10b - Switching Time Waveforms

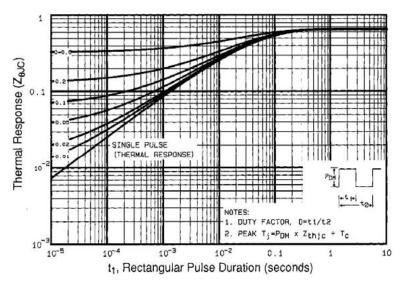


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



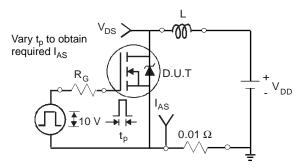


Fig. 12a - Unclamped Inductive Test Circuit

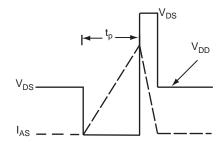


Fig. 12b - Unclamped Inductive Waveforms

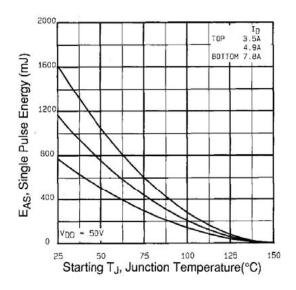


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

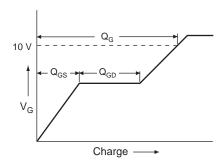


Fig. 13a - Basic Gate Charge Waveform

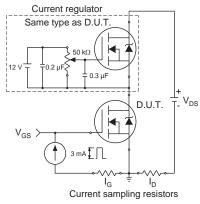
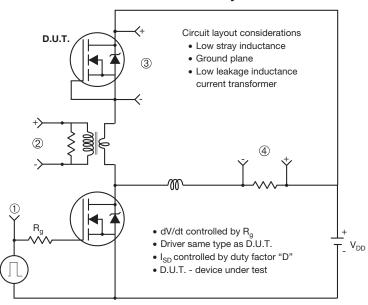


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



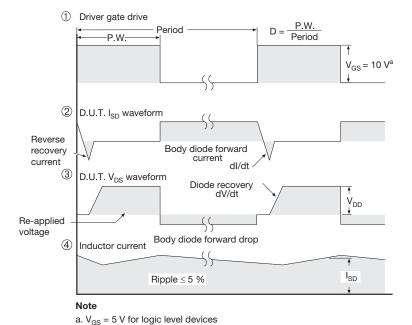
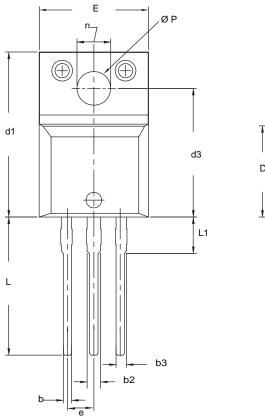
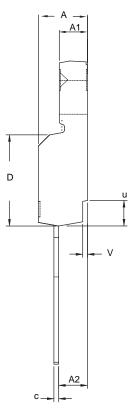


Fig. 14 - For N-Channel



TO-220 FULLPAK (HIGH VOLTAGE)





DIM.	MILLIN	METERS	INCHES		
	MIN.	MAX.	MIN.	MAX.	
Α	4.570	4.830	0.180	0.190	
A1	2.570	2.830	0.101	0.111	
A2	2.510	2.850	0.099	0.112	
b	0.622	0.890	0.024	0.035	
b2	1.229	1.400	0.048	0.055	
b3	1.229	1.400	0.048	0.055	
С	0.440	0.629	0.017	0.025	
D	8.650	9.800	0.341	0.386	
d1	15.88	16.120	0.622	0.635	
d3	12.300	12.920	0.484	0.509	
E	10.360	10.630	0.408	0.419	
е	2.54	BSC	0.100 BSC		
L	13.200	13.730	0.520	0.541	
L1	3.100	3.500	0.122	0.138	
n	6.050	6.150	0.238	0.242	
ØΡ	3.050	3.450	0.120	0.136	
u	2.400	2.500	0.094	0.098	
V	0.400	0.500	0.016	0.020	

ECN: X09-0126-Rev. B, 26-Oct-09 DWG: 5972

Notes

- To be used only for process drawing.
 These dimensions apply to all TO-220, FULLPAK leadframe versions 3 leads.
 All critical dimensions should C meet C_{pk} > 1.33.
 All dimensions include burrs and plating thickness.
 No chipping or package damage.



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